

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Addease COMMISSIONER FOR PATENTS PO Box 1430 Alexandra, Virginia 22313-1450 www.webjo.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/550,682	07/31/2006	Katsumi Shibayama	46884-5426	8343
55694 7550 062212008 DRINKER BIDDLE & REATH (DC) 1500 K STREET, N.W.			EXAMINER	
			PATEL, REEMA	
SUITE 1100 WASHINGTO	N. DC 20005-1209		ART UNIT	PAPER NUMBER
	,		2812	
			MAIL DATE	DELIVERY MODE
			06/27/2008	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

# Application No. Applicant(s) 10/550.682 SHIBAYAMA, KATSUMI Office Action Summary Examiner Art Unit REEMA PATEL 2812 -- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --Period for Reply A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS. WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION. Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status 1) Responsive to communication(s) filed on 18 April 2008. 2a) This action is FINAL. 2b) This action is non-final. 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213. Disposition of Claims 4) Claim(s) 2-5.10.12 and 14 is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration. 5) Claim(s) \_\_\_\_\_ is/are allowed. 6) Claim(s) 2-5,10,12 and 14 is/are rejected. 7) Claim(s) \_\_\_\_\_ is/are objected to. 8) Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement. Application Papers 9) The specification is objected to by the Examiner. 10) ☐ The drawing(s) filed on 29 August 2007 is/are: a) ☐ accepted or b) ☐ objected to by the Examiner. Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a). Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152. Priority under 35 U.S.C. § 119 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some \* c) None of: Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). \* See the attached detailed Office action for a list of the certified copies not received. Attachment(s) 1) Notice of References Cited (PTO-892) 4) Interview Summary (PTO-413) Paper No(s)/Mail Date. Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO/SB/08) 5) Notice of Informal Patent Application

Paper No(s)/Mail Date 2/7/08

6) Other:

Page 2

Application/Control Number: 10/550,682

Art Unit: 2812

### DETAILED ACTION

### Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 2/26/08 has been entered.

#### Information Disclosure Statement

 The information disclosure statement (IDS) was submitted on 2/7/08. The submission is in compliance with the provisions of 37 CFR 1.97. Accordingly, the information disclosure statement has been considered by the examiner.

## Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

4. Claims 10, 3-5, 12, and 14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yoneta et al. (U.S. 2003/0034496 A1; hereinafter 'Yoneta') in view of Minami et al. (2002/0176158 A1; hereinafter 'Minami'), Albagli et al. (U.S. 2005/0072931 A1; hereinafter 'Albagli'), and Yoshida et al. (U.S. 5,386,122; hereinafter 'Yoshida').

Application/Control Number: 10/550,682 Page 3

Art Unit: 2812

Regarding claims 10, 3, 12, and 14, Yoneta discloses a photodiode array comprising a semiconductor substrate, wherein a plurality of photodiodes are formed in

an array on an opposite surface side to an incident surface of light to be detected

([0038]-[0039]). Additionally, Yoneta discloses forming an anti-reflection film on the side

of the incident surface of light to be detected ([0039]).

Yet, Yoneta does not disclose the following:

a) A resin film is provided so as to cover at least regions corresponding to

regions where the photodiodes are formed on a side of the incident surface of

the light to be detected;

b) A scintillator panel is arranged opposite to the incident surface of the light to

be detected;

c) An optical resin is provided so as to fill a space between a light exit surface of

the scintillator panel and the resin film.

7. Regarding (a), Yoneta discloses forming an antireflective film on an entire side of

the incident surface of light to be detected which overlaps photodiodes formed on the

opposite side of the substrate ([0039]) but does not disclose forming a resin film.

However, Minami discloses forming a resin film so as to protect an underlying anti-

reflective material on a substrate ([0044]-[0045]). Incorporating a resin film, as taught

by Minami, on the anti-reflective film in the invention of Yoneta would result in the resin

film covering all the regions corresponding to regions where the photodiodes are formed

and on the side of the incident surface of light to be detected. Minami discloses that

the thickness of the resin film is less than 100 microns ([0046]) but does not

Page 4

Application/Control Number: 10/550,682

Art Unit: 2812

disclose that the thickness must be within the range of 1-50 microns. However, it would have been obvious to one having ordinary skill in the art at the time the invention was made to select the resin film thickness to be between 1 and 50 microns, since it has been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233. Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to modify Yoneta with forming a 1-50 micron thick resin film on an incident surface of light to be detected so as to protect an underlying anti-reflective coating.

- 8. Regarding (b), Yoneta discloses a scintillator panel but discloses that it is formed on the side of the incident surface of light to be detected ([0039]). However, Albagli discloses forming a scintillator panel on a side opposite to the incident light surface so as to reduce image blurring ([0025]-[0028]). Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the invention of Yoneta with a scintillator panel opposite to the incident surface of detected light, as taught by Albagli, so as to reduce image blurring.
- 9. Regarding (c), Yoneta discloses a scintillator but does not disclose forming an optical resin between the scintillator panel and substrate. However, Yoshida discloses an epoxy or acrylic resin in between a scintillator panel and a substrate containing a photodiode array so as to act as an adhesive (col 5, lines 53-55; col 5, line 63 col 6, line 4). Therefore, it would have been obvious to one having ordinary skill in the art at

Application/Control Number: 10/550,682 Page 5

Art Unit: 2812

the time the invention was made to modify the invention of Yoneta to provide an optical resin, as taught by Yoshida, so as to adhere the scintillator panel to the photodiode array.

- 10. Regarding claim 4, Yoneta et al. discloses the semiconductor substrate is provided with an impurity region between the photodiodes adjacent to each other for separating the photodiodes from each other (f0039).
- 11. Regarding claim 5, Yoneta et al. discloses a high-impurity-concentration layer of the same conductivity type as the semiconductor substrate is formed on the incident surface side of the light to be detected, in the semiconductor substrate ([0039]).
- Claim 2 is rejected under 35 U.S.C. 103(a) as being unpatentable over Yoneta et al. (2003/0034496 A1) as modified by Minami et al. (2002/0176158 A1), Albagli et al. (U.S. 2005/0072931 A1), and Yoshida et al. (U.S. 5,386,122) as applied to claim 1 above, and further in view of Allison (U.S. 3,748.546).
- 13. Regarding claim 2, Yoneta, Minami, Albagli, and Yoshida disclose a photodiode array but do not disclose that it contains a plurality of depressions having a predetermined depth. However, Allison discloses forming a plurality of depressions in a photodiode array on the opposite surface side to the incident surface of light to be detected, wherein each said photodiode is formed in a bottom portion of the associated depression (col 2, lines 33-45; col 3, lines 10-21; Fig. 1). The purpose of doing this is to ensure that light that enters the device also enters the space charge region, which henceforth increases the efficiency of the device (col 4, lines 9-21). Therefore, it would

Application/Control Number: 10/550,682

Art Unit: 2812

have been obvious to one having ordinary skill in the art at the time the invention was made to modify the invention of Yoneta as modified by Minami, Albagli, and Yoshida with forming a plurality of depressions wherein each photodiode is formed in a bottom portion of the associated photodiode, as taught by Allison, so as to increase the efficiency of the photo-detector device.

## Response to Arguments

14. Applicant's arguments with respect to claims 10, 2-5, 12, and 14 have been considered but are moot in view of the new ground(s) of rejection

#### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to REEMA PATEL whose telephone number is (571)270-1436. The examiner can normally be reached on M-F. 8:00-4:30 ET.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Charles Garber can be reached on (571)272-2194. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information For published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Reema Patel/ Examiner, Art Unit 2812 6/18/08

/Charles D. Garber/ Supervisory Patent Examiner, Art Unit 2812